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1 Introduction

Antimony selenide (Sb_2Se_3) is a candidate thin film photovoltaic (PV) material, which has the desirable properties of being Earth abundant, low toxicity and stable.¹

Beyond that, the material has relatively simple low-cost production methods due to it being a binary V–VI compound and its potential as a thin-film PV absorber is high due to its high absorption coefficient ($>10^5$ cm⁻¹ below 2 eV), which is 1000 times greater than that of silicon.^{3,4} This makes it of great interest to those seeking to diversify the field of photovoltaics and find a scalable thin film technology to aid in achieving the target of terawatt scale-up. It has also attracted attention in the field of photocatalytic hydrogen evolution.^{5–7} A recent paper

Sb $5s^2$ lone pairs and band alignment of Sb₂Se₃: a photoemission and density functional theory study⁺

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The presence of a lone pair of 5s electrons at the valence band maximum (VBM) of Sb_2Se_3 and the resulting band alignments are investigated using soft and hard X-ray photoemission spectroscopy in parallel with density functional theory (DFT) calculations. Vacuum-cleaved and exfoliated bulk crystals of Sb_2Se_3 are analysed using laboratory and synchrotron X-ray sources to acquire high resolution valence band spectra with both soft and hard X-rays. Utilising the photon-energy dependence of different orbital cross-sections and corresponding DFT calculations, the various orbital contributions to the valence band could be identified, including the 5s orbital's presence at the VBM. The ionization potential is also determined and places the VBM at 5.13 eV below the vacuum level, similar to other materials with $5s^2$ lone pairs, but far above those of related materials without lone pairs of electrons.

reports a direct band gap for Sb_2Se_3 of 1.180 eV at 320 K, increasing to 1.316 eV at 20 K (ref. 8), nearly ideal for a singlejunction device. The maximum recorded solar cell power conversion efficiency (PCE) for this material has already reached 9.2% using core-shell structured nanorod array solar cells,⁹ and the improvement has been rapid as efficiencies of just 2.1% were reported in 2014 (ref. 10). The number of papers published on Sb_2Se_3 is now increasing exponentially and several labs have now independently reported planar Sb_2Se_3 solar cells with PCE in excess of 6% (ref. 11–19).

One of the most intriguing properties of Sb_2Se_3 is its onedimensional nanoribbon structure as shown in Fig. 1. Strongly covalently bonded 'ribbons' along the *c*-axis are held together parallel to each other by weaker van der Waals interactions. It has been reported that this ribbon structure causes anisotropic conductivity in the bulk material because of the low carrier mobility across ribbons, resulting in crystal orientationdependence of the solar cell performance of this material, along with potential benign or self-healing grain boundaries.^{15,20} The origin of this anisotropic crystal structure is attributed to the presence of a stereochemically active ns^2 lone pair orbital at the upper edge of the valence band, a property that has been shown to have a significant influence on the optoelectronic properties of materials possessing it.^{21–24}

The aim of this study is to show experimentally the presence of a stereochemically active lone pair orbital at the valence

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[†] Electronic supplementary information (ESI) available: SEM image and EDX spectrum, indicating Sb and Se weight and atomic percentages. Survey HAXPES spectrum, illustrating the plasmon loss feature at a binding energy of 17.9 eV higher than each core level peak. See DOI: 10.1039/d0tc03470c

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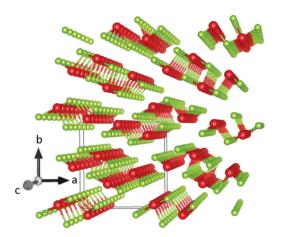


Fig. 1 Sb₂Se₃ crystal structure drawn in VESTA 3 (ref. 2) – antimony atoms are shown in red and selenium atoms in green. The solid line cuboid represents the unit cell. The axes labels correspond to the *Pbnm* setting of space group 62.

band edge of Sb₂Se₃ and how this influences the ionization potential and natural band alignment of the material. The ionization potential - the separation between valence band maximum and vacuum level - for Sb₂Se₃ was measured using X-ray photoemission spectroscopy (XPS) ($h\nu = 1.487$ keV) of the valence band and secondary electron cutoff. Valence-band and core-level data were obtained from an Sb₂Se₃ bulk crystal, exposed to surface oxidation effects and cleaved in vacuum, using hard X-ray photoemission spectroscopy (HAXPES) ($h\nu$ = 5.921 keV). As well as providing slightly better spectral resolution than conventional lab-based XPS, the synchrotron photoemission beamline could be adjusted to deliver soft X-rays ($h\nu = 0.800$ keV) to the same position on the crystal, without changing any other experimental conditions. Using multiple energies allows for the exploitation of the photonenergy-dependence of the orbital cross-sections. This can be used to discriminate between different orbitals within the valence band when comparing to density functional theory (DFT) calculations.

The energy dependence of photoionization cross-sections refers to the way in which an orbital's photoionization probability varies with different incident photon energies. The rate of photoemission tends to decrease with increasing incident photon energy (at least sufficiently far from the threshold energy). This decrease is the result of the wavelength of the incident photon becoming more comparable with the radial extension of the valence band orbitals and the resulting cancellation of terms contributing to the transition matrix element. In general, s-orbital photoionization cross-sections decrease more gradually with increasing photon energy relative to other orbitals because of the more contracted nature of the orbitals (see Fig. 2). Therefore, the relative contribution to the valence band photoemission spectrum from s-orbitals is generally expected to be greater in measurements taken with hard X-rays than with soft X-rays. The cross sections for the Sb and Se orbitals are also compared in Table 1 for the two photon energies used in our synchrotron radiation measurements.

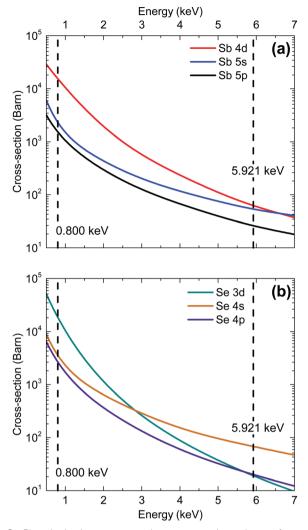


Fig. 2 Photoionization cross-section energy dependence for each valence orbital in (a) antimony and (b) selenium. $^{25}\,$

Table 1 Photoionization cross sections of the Sb_2Se_3 orbitals at the two different photon energies used for the synchrotron-radiation photoemission measurements.²⁵

Orbital	Cross section (barns)		
	0.800 keV	5.921 keV	
Sb 4d	15466	63	
Sb 5s	2311	54	
Sb 5p	1507	26	
Se 3d	18576	19	
Se 4s	3600	68	
Se 4p	2646	20	

Another area of interest is to what extent surface oxidation of the Sb_2Se_3 material affects cell performance. Photoemission spectroscopy is a commonly used tool for identifying elemental composition and chemical states present at the surface of a sample. However, the XPS investigations of Sb_2Se_3 surface oxidation have thus far seen some conflicting results. A 2014 study by Liu *et al.* stated that the presence of an O 1s peak in their data (532.9 eV) suggests the existence of Sb₂O₃. However, Sb 3d and Sb 4d states would be expected to exhibit additional chemically shifted components to higher binding energy if this were the case, corresponding to the two different chemical environments present in the sample.¹⁰ We therefore argue that the O 1s peak observed is a result of surface physisorbed oxygen that is not interacting chemically with the Sb₂Se₃ crystal. Further studies carried out in 2017 by Wang et al.²⁶ and Chen et al.²⁷ show conflicting assignments in their reported peak positions of elemental Se, despite both studies coming from the same group, as later highlighted in detail by Shiel et al.¹³ The XPS interpretation by Shiel et al. is consistent with Wang et al. and others,^{28,29} though the oxide components only contributed a minor proportion of the measured Sb 3d signals. The results presented here, comparing as-received oxidised crystals with oxygen-free in-vacuum cleaved Sb₂Se₃ crystals, provide additional information to inform future photoemission analysis of Sb₂Se₃.

2 Experimental and computational details

The Sb₂Se₃ single crystals utilised in this work were prepared via the Bridgman melt-growth technique using a single-zone vertical furnace. Granular Sb₂Se₃ source material (5N purity, Alfa Aesar) was manually ground in a mortar and pestle with the resulting powder placed in a quartz tube with 4 mm internal diameter. The tube was flushed three times with Ar gas then evacuated to $\sim 10^{-5}$ mbar to evaporate residual volatile compounds. The tube was filled with Ar at a pressure of 100 mbar immediately before sealing, intended to suppress the sublimation of Sb₂Se₃ that occurs at low pressure due to the high vapour pressure of Sb₂Se₃ (ref. 10). This was necessary to avoid the formation of large gas bubbles in the crystal boules and also to prevent unwanted vapour transport of material away from the melt-grown crystals. The sealed ampoule was placed with the bottom tip in line with the peak of the temperature profile in the furnace and heated to 620 °C (the melting point of Sb₂Se₃ is 611 °C). It was then held for around 6 hours to allow full melting and homogenisation of the powder. The ampoule was then lowered through the natural temperature gradient of the furnace, at 0.6 °C mm⁻¹ in the working range, towards the lower, open end of the furnace (at room temperature), at a rate of 1.15 mm h^{-1} for 7 days. The ampoule was rotated at a low speed throughout to ensure homogeneous heating. The identity and crystallographic orientation of Sb₂Se₃ was confirmed by X-ray diffraction and Raman spectroscopy as described in detail for these crystals by Fleck et al. in ref. 30. Its chemical composition was further confirmed as 40% Sb and 60% Se by energy dispersive X-ray (EDX) analysis in a scanning electron microscope (SEM), this being consistent with the expected 2:3 stoichiometry. An SEM image and some EDX data are shown in Fig. S1 (ESI[†]). This used an Oxford INCA X-act EDX detector in a JEOL JSM 6610 SEM. The Sb₂Se₃ manufacturers' purity was 99.999% by metals basis analysis. We identified chlorine as being the most important non-metallic impurity using secondary ion mass spectroscopy, making the crystals n-type with $n = 10^{17}$ cm⁻³ (ref. 31). Extracted crystals were found to cleave easily in one plane to reveal parallel reflective facets, demonstrated to be the (010) crystal plane (using the *Pbnm* space group setting).³² Given that the weakest van der Waals interactions lie along the *b* axis, this behaviour is expected.³³ This (010) crystal surface was exposed to air and is the "as-received" crystal referred to below as opposed to the "*in situ* cleaved" crystal which refers to the crystal cleaved in ultrahigh vacuum. For the synchrotron photoemission measurements, this was done by gluing a post to the crystal surface, and cleaving by hitting the post with a wobble stick. For the laboratory XPS measurements, this was done by exfoliating surface layers of the crystal using carbon tape attached to a sample-transfer arm.

Hard X-ray photoemission spectroscopy was carried out at the I09 beamline at the Diamond Light Source facility. X-ray energies of 5.921 keV and 0.800 keV were selected using doublecrystal Si(111) monochromator followed by a Si(004) channelcut crystal. The energy resolution was 250 meV, determined by fitting a Gaussian-broadened Fermi-Dirac distribution to the Fermi edge of a gold reference sample. The spectra were acquired using a Scienta Omicron EW4000 high-energy analyser with an acceptance angle of $\pm 28^{\circ}$. The crystals were first measured as-received and then were cleaved in situ to expose a pristine (010) surface and to prevent any re-oxidation of the surface. All peak positions from curve fitting are reported with an error of ± 0.05 eV. XPS was performed using a SPECS monochromatic Al K α source ($h\nu$ = 1486.6 eV) and data was collected with a PSP Vacuum Technologies hemispherical electron-energy analyser with an acceptance angle of $\pm 3^{\circ}$. The energy resolution was 400 meV, determined by fitting a Gaussian-broadened Fermi-Dirac distribution to the Fermi edge of a silver reference sample. Photoemission spectra were curve fitted using CASAXPS software with Voigt lineshapes after subtracting a Shirley background.34

DFT calculations were performed within periodic boundary conditions using the Vienna Ab initio Simulation Package (VASP).35-38 The screened hybrid exchange correlation functional HSE06 was used,³⁹ for geometry optimization and electronic structure calculations of Sb₂Se₃. To account for the ribbon nature of the Sb₂Se₃ structure, the D3 dispersion correction from Grimme et al. was also included in density of states (DoS) calculations,⁴⁰ while spin-orbit coupling (SOC) was included for all calculations. A plane wave energy cutoff of 350 eV was used for all calculations, with a Γ -centered k-point mesh with spacing between k-points of 0.27 $Å^{-1}$ used for bulk calculations of Sb₂Se₃. These values were obtained through convergence testing on the total energy, using criteria of 1 meV per atom and 10 meV per atom for k-mesh and energy cutoff, respectively. Prior to the calculation of the electronic density of states, the structure was relaxed (during which the plane-wave energy cutoff was increased to 455 eV to avoid errors arising from Pulay stress) with HSE06+D3 until the forces per atom were below 0.01 eV Å⁻¹, which results in lattice parameters in agreement with experiment.41

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3 Results

3.1 Core-level HAXPES

Core-level analysis of photoemission measurements allows for the identification of surface chemical composition and the extent to which surface contamination has chemically altered the surface through examination of the chemical shift in characteristic elemental lines. Materials largely unaffected by a moderate level of contamination are favoured since they may not necessarily need manufacturing in ultra clean environments – thus minimising production costs and increasing viability of widespread adoption. Surface contamination can also have an effect on the formation of favourable interfaces in photovoltaic devices.¹³ Therefore, a good understanding of how to identify these contaminants is essential. A list of core level peak positions and full widths at half maximum (FWHM) values for an as-received and *in situ* cleaved Sb₂Se₃ bulk crystal can be found in Table 2.

Fig. 3 shows Sb 3d_{3/2} and 3d_{5/2} peaks before and after in situ cleaving to expose a pristine surface. In both Fig. 3(a) and (b), the agreement between data and the fitted envelope is good. The highest intensity peaks seen in both Fig. 3(a) and (b) are from antimony bonded to selenium (red line). The spectrum recorded from the contaminated sample in Fig. 3(a) is complicated by the overlap of peaks due to the O 1s state (magenta and cyan), as well as chemically shifted Sb 3d states bonded to oxygen (blue lines). This feature is attributed to Sb₂O₃ due to the 3d_{5/2} peak position of 530.7 eV coinciding with literature values for Sb₂O₃.⁴² Despite this agreement, the evidence is not enough to be conclusive - a previous paper reported Sb 3d_{3/2} positions of Sb₂O₃ and Sb₂O₅ as 539.8 eV and 540.4 eV respectively,43 compared to a position measured here of 540.1 eV. The smallest of the fitted peaks in Fig. 3(a) (cyan) has a measured peak position also of 530.7 eV which broadly agrees with current literature for the O 1s state in an Sb₂O₃ environment (529.8 eV)44 and this same conclusion has been reached in related work.²⁴ The remaining O 1s peak (magenta) has been labelled as adventitious oxygen weakly adsorbed on the surface, but could also be a result of atmospheric CO₂ surface physisorption. However, the position of the carbon 1s peak at 285.4 eV, indicates this is unlikely. The assignment of

Table 2 Core level binding energy (BE) and width (FWHM) of all fitted peaks in the HAXPES spectra from an as-received and an *in situ* cleaved Sb_2Se_3 bulk crystal. The element in brackets denotes which species is responsible for the chemical shift. "Sb(Elem.)" denotes elemental selenium and "O(Adv.)" denotes adventitious oxygen

	As-receive	As-received		In situ cleaved	
Peak	BE (eV)	Width (eV)	BE (eV)	Width (eV)	
Sb(Se) 3d _{5/2}	529.53	0.71	529.71	0.62	
Sb(O) 3d _{5/2}	530.72	0.90	_	_	
Sb(Se) $4d_{5/2}$	33.41	0.56	33.47	0.46	
$Sb(O) 4d_{5/2}$	34.62	0.83	_	_	
$Se(Sb) 3d_{5/2}$	54.11	0.68	54.16	0.58	
Se(Elem.) 3d _{5/2}	55.78	1.13	_	_	
O(Sb) 1s	530.66	0.60	_	_	
O(Adv.) 1s	531.17	0.60	—	—	

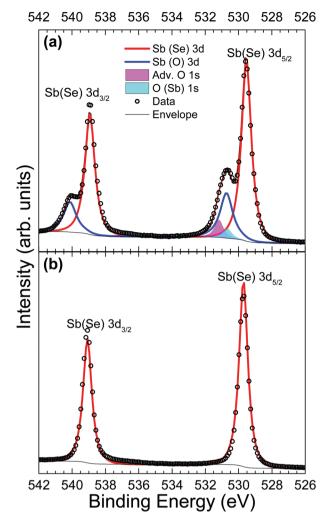


Fig. 3 Sb 3d HAXPES data from an Sb_2Se_3 crystal (a) before and (b) after *in situ* cleaving.

all these extra peaks in Fig. 3(a) to oxygen-related species caused by atmospheric exposure is further supported by the data from the *in situ* cleaved crystal in Fig. 3(b) which shows only clean, sharply defined selenium bound antimony 3d peaks in this binding energy region.

A comparison of Se 3d data from a contaminated as-received and an in situ cleaved crystal is presented in Fig. 4. Unfortunately, the spectra are complicated by the presence of plasmon loss features from the Sb 4d states. The valence band plasmon energy is found to be 17.9 eV. This is confirmed by the observation of loss features at a binding energy 17.9 eV higher than each core level peak, as shown in the survey scan in Fig. S2 of the ESI.[†] However, these have been accounted for by fitting them according to the same doublet separation and FWHM of the Sb 4d core levels. It was initially thought that the chemically shifted peaks in Fig. 4a (blue line) were caused by SeO₂ states, similar to those seen in the Sb 3d data, however related literature suggests that a SeO₂ chemically shifted Se $3d_{5/2}$ peak should appear at higher binding energy ($\sim 59 \text{ eV}^{29,45,46}$) than that observed. Shiel et al. identified these peaks as free elemental selenium¹³ which corresponds well with the

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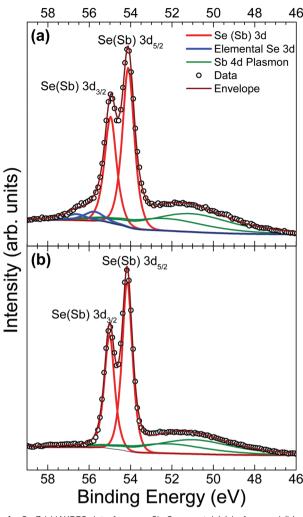


Fig. 4 Se 3d HAXPES data from an ${\rm Sb}_2{\rm Se}_3$ crystal (a) before and (b) after in situ cleaving.

presence of Sb_2O_3 seen in the Sb 3d state; since the selenium from the pure Sb_2Se_3 crystal must become unbound when it is replaced by oxygen to form the Sb_2O_3 on the surface. As expected, the peaks associated with elemental Se are also absent after *in situ* cleaving, further confirming that exposure to standard atmospheric conditions does not impact the bulk chemistry of the material, only the surface.

3.2 Valence band photoemission

Valence band (VB) spectra were obtained by collecting photoelectrons excited by monochromatic X-rays of 5.921 keV both before and after *in situ* cleaving of the crystal, to look at the effects of surface contamination on VB states. An additional data set was taken from the *in situ* cleaved crystal at a softer X-ray energy of 0.800 keV to utilise the energy dependence of photoionization cross sections as a way of verifying valence orbital contributions from the changing intensities of VB features. The valence band maximum (VBM) is set to 0 eV on the binding energy scale for both theoretical and experimental data in order to compare their spectral features. DFT is used here to calculate the contributions of the different orbitals to

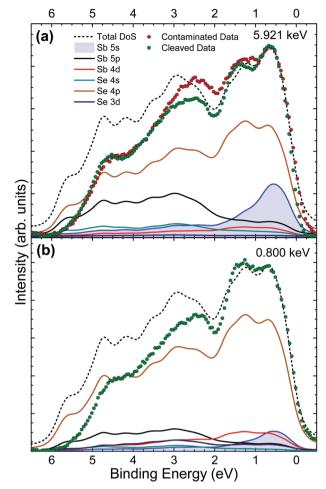


Fig. 5 VB XPS spectra from an Sb₂Se₃ single crystal sample for (a) hard X-rays with a photon energy of 5.921 keV (HAXPES), before and after *in situ* crystal cleaving; and (b) soft X-rays with a 0.800 keV photon energy after *in situ* cleaving. Both are plotted with total and partial theoretical VB DoS calculations.

the overall valence band occupation in Sb_2Se_3 . Then, comparison of the theory with experimental results enables orbital hybridization and its effect on the VB spectra and band alignment to be determined.

In Fig. 5(a) it can be seen that there are broad similarities in the data from as-received and *in situ* cleaved crystals. This is expected because the 5.921 keV X-ray energy is not very surface sensitive – the resulting photoelectron inelastic mean free path is such that the effective probing depth is about 20 nm. Therefore, the contribution to the spectrum from the surface oxidised layer is relatively small. The main differences can be seen between 3 eV and 1 eV where the data from the *in situ* cleaved crystal is of significantly lower intensity. The additional intensity for the as-received crystal is attributed to a thin surface layer of Sb₂O₃. No significant change in the spectra at low binding energy is seen after *in situ* cleaving, which indicates that the Sb₂O₃ contribution to the data from the contaminated crystal does not affect the spectrum in the vicinity of the VBM.

The data from the *in situ* cleaved crystal agrees well with the theoretically predicted DoS at low binding energies, however

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the intensities fall off increasingly with binding energy despite replicating the overall shape of the total DoS (black short dashed line) fairly well. This effect is most likely due to final-state relaxation effects which have been observed to shift high binding energy valence band features to lower binding energies.^{23,24,47} Other possible contributors to this lack of intensity arise from DFT inaccuracies in dealing with the van der Waals bonding present in this material and also the lack of a well established or optimal method for background subtraction of valence band photoemission data. The DoS predicts a large contribution to the spectra from the Sb 5s state at low binding energy which is supported by the strong agreement with the experimental data in this region. This result is significant because it suggests a lone pair of electrons in the Sb 5s state, causing this group V element to be in an Sb(III) oxidation state, instead of the naïvely expected Sb(v) state for a group V element. The presence of this lone pair Sb 5s state contributes to the observed layer-like ribbon structure as summarised by Walsh et al.²¹

Due to the photoionization cross-section energy dependence (Fig. 2), the cross-section corrected DoS for 0.800 keV in Fig. 5(b) predicts lower relative contributions to the spectra from s orbitals, and additional intensity from d and p orbitals, compared with the calculated cross-section corrected DoS for 5.921 keV in Fig. 5(a). This is consistent with the experimental data, which shows reduced relative intensity in the initial feature near the VB onset, confirming that the Sb 5s lone pair state is in fact occupied and contributing intensity in this region. Strong interaction between the cation s and anion p orbitals results in high-energy antibonding states with a considerable degree of cation s character at the top of the upper valence band.²¹ The hybridization of the Sb 5s states with Se 4p states results in intensity from the Se 4p states also occurring at the VBM. In other words, in the absence of the Sb 5s lone pair states at top of the valence band, the VBM would be lower in energy, further from the vacuum level.

The implications of the presence of stereochemically active lone pairs at the valence band edge has been explored previously, such as the work on the different tin sulfide phases.^{23,48} The mixing of the p-orbitals with the ns^2 lone pair effectively 'drags' the valence band edge to a lower binding energy and leads to the phases that possess this lone pair to have a significantly lower band gap and ionization potential than those without. By comparing this work with those results and similar work performed by the same group on CuSbS₂,²⁴ it can be seen that the ionization potentials of $CuSbS_2$, SnS and Sn_2S_3 (the tin sulfide phases possessing a lone pair) range from 4.66 eV to 4.98 eV. However, chalcogenide materials that are similar but lack an ns^2 lone pair at the top of the valence band, such as SnS₂ and CdS, have ionization potentials ranging from 5.67 eV to 6.70 eV. In order to see how Sb₂Se₃ fits in with this trend, the ionization potential of an identical crystal as used in the HAXPES was determined. By measuring the valence band edge and secondary electron cut-off (SEC) of the XPS spectrum, as shown in Fig. 6, and using eqn (1) (in which $h\nu$ is the incident X-ray excitation energy, $h\nu = 1486.6$ eV) the ionization potential can be calculated.

$$IP = h\nu - (SEC - VBM)$$
(1)

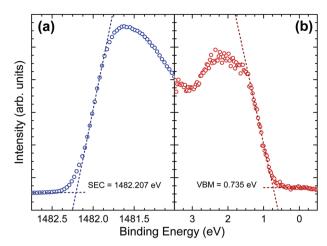


Fig. 6 (a) Secondary electron cut-off (blue) and (b) valence band maximum (red) of *in situ* cleaved Sb_2Se_3 bulk crystals with straight line fits used to determine the binding energy of the cut-offs. The incident photon energy is 1486.6 eV.

The measured ionization potential for the Sb₂Se₃ crystal in this study was found to be 5.13 eV. As shown in Fig. 7, this is towards the upper end of the values for other $5s^2$ lone-paircontaining materials, but certainly well below many of the materials without lone pairs. This demonstrates that not only is understanding the lone pair model important from a structural perspective, but it also affects the electronic properties. In the context of photovoltaics, understanding the dependence of ionization potential on the lone pairs could inform band alignment engineering between absorber and window layers for improving performance of solar cells. For example, based on unfavourable band alignments, CdS has previously been suggested to be a non-optimal solar cell junction partner for SnS (ref. 23 and 51) and CuSbS₂ (ref. 24).

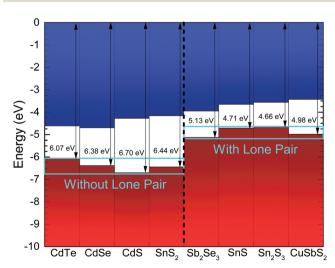


Fig. 7 Ionization potential for Sb_2Se_3 from the photoemission results in Fig. 6, compared with literature values for other materials.^{23,24,49,50} The zero of the energy scale corresponds to the vacuum level. The materials are labelled as without or with lones pair $5s^2$ electrons.

4 Conclusion

To better understand the electrical properties, chemical composition and effects of surface contamination on Sb_2Se_3 , high-resolution core-level and valence band photoemission results have been analysed, and the latter has been compared with theoretical calculations. *In situ* cleaving of an Sb_2Se_3 crystal, that had been exposed to atmospheric conditions, removes all observed effects from surface oxidation in our core-level HAXPES results, indicating that this exposure does not significantly impact the bulk of the crystal.

Using the energy dependence of photoionization crosssections, shifts in valence band photoemission features have been linked to bonding mechanisms. The agreement observed between the theoretical VB DoS and the experimental photoemission data near the VBM provides strong evidence that Sb_2Se_3 exhibits contributions to the VB spectra from a lone pair of electrons in the Sb 5s state.

The Sb 5s lone pair states at the top of the valence band are responsible for the relatively high VBM on an absolute energy scale and low ionization potential of 5.13 eV, as measured by XPS. This band alignment has been compared with related materials and will inform future design of Sb₂Se₃ solar cells and other devices.

Author contributions

The crystals were grown by TDCH under the guidance of KD. The synchrotron photoemission data was collected by HS, LAHJ, JENS, MJS, TJF, PKT and T-LL and analysed by CHD and HS with input from TDV. The XPS data was collected by HS under the guidance of VRD. The DFT calculations were performed and analysed by CNS and DOS. Photovoltaic device-related band alignment insights were provided by JDM and KD. The manuscript was written by CHD, HS and TDV. All authors commented on and edited the manuscript.

Conflicts of interest

The authors have no conflicts of interest.

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References

- 1 X. Wang, R. Tang, C. Wu, C. Zhu and T. Chen, *J. Energy Chem.*, 2018, 27, 713–721.
- 2 K. Momma and F. Izumi, J. Appl. Crystallogr., 2011, 44, 1272–1276.
- 3 Y. Zhou, M. Leng, Z. Xia, J. Zhong, H. Song, X. Liu, B. Yang, J. Zhang, J. Chen, K. Zhou, J. Han, Y. Cheng and J. Tang, *Adv. Energy Mater.*, 2014, 4, 1301846.
- 4 H. El-Shair, A. Ibrahim, E. A. El-Wahabb, M. Afify and F. A. El-Salam, *Vacuum*, 1991, **42**, 911–914.
- 5 R. R. Prabhakar, W. Septina, S. Siol, T. Moehl, R. Wick-Joliat and S. D. Tilley, *J. Mater. Chem. A*, 2017, *5*, 23139–23145.
- L. Zhang, Y. Li, C. Li, Q. Chen, Z. Zhen, X. Jiang, M. Zhong,
 F. Zhang and H. Zhu, ACS Nano, 2017, 11, 12753–12763.
- 7 W. Yang, J. H. Kim, O. S. Hutter, L. J. Phillips, J. Tan, J. Park, H. Lee, J. Major and J. S. Lee, *Nat. Commun.*, 2020, **11**, 861.
- 8 M. Birkett, W. M. Linhart, J. Stoner, L. J. Phillips, K. Durose,
 J. Alaria, J. D. Major, R. Kudrawiec and T. D. Veal, *APL Mater.*, 2018, 6, 084901.
- 9 Z. Li, X. Liang, G. Li, H. Liu, H. Zhang, J. Guo, J. Chen, K. Shen, X. San, W. Yu, R. E. I. Schropp and Y. Mai, *Nat. Commun.*, 2019, **10**, 125.
- 10 X. Liu, J. Chen, M. Luo, M. Leng, Z. Xia, Y. Zhou, S. Qin, D.-J. Xue, L. Lv, H. Huang, D. Niu and J. Tang, ACS Appl. Mater. Interfaces, 2014, 6, 10687–10695.
- 11 C. Chen, L. Wang, L. Gao, D. Nam, D. Li, K. Li, Y. Zhao, C. Ge, H. Cheong, H. Liu, J. Song and H. Tang, ACS Energy Lett., 2017, 2, 2125–2132.
- 12 O. S. Hutter, L. J. Phillips, K. Durose and J. Major, *Sol. Energy Mater. Sol. Cells*, 2018, **188**, 177–181.
- H. Shiel, O. Hutter, L. Phillips, M. Al Turkestani, V. R. Dhanak,
 T. D. Veal, K. Durose and J. D. Major, *J. Phys. Energy*, 2019,
 1, 045001.
- 14 D.-B. Li, X. Yin, C. R. Grice, L. Guan, Z. Song, C. Wang, C. Chen, K. Li, A. J. Cimaroli, R. A. Awni, D. Zhao, H. Song, W. Tang, Y. Yan and J. Tang, *Nano Energy*, 2018, 49, 346–353.
- R. E. Williams, Q. M. Ramasse, K. P. McKenna, L. J. Phillips,
 P. J. Yates, O. S. Hutter, K. Durose, J. D. Major and B. G. Mendis, ACS Appl. Mater. Interfaces, 2020, 12, 21730–21738.
- 16 J. Tao, X. Hu, Y. Guo, J. Hong, K. Li, J. Jiang, S. Chen, C. Jing, F. Yue, P. Yang, C. Zhang, Z. Wu, J. Tang and J. Chu, *Nano Energy*, 2019, **60**, 802–809.
- 17 K. Li, S. Wang, C. Chen, R. Kondrotas, M. Hu, S. Lu, C. Wang, W. Chen and J. Tang, *J. Mater. Chem. A*, 2019, 7, 9665–9672.
- 18 X. Wen, C. Chen, S. Lu, K. Li, R. Kondrotas, Y. Zhao, W. Chen, L. Gao, C. Wang, J. Zhang, G. Niu and J. Tang, *Nat. Commun.*, 2018, 2018, 2179.

- 19 K. Shen, Y. Zhang, X. Wang, C. Ou, F. Guo, H. Zhu, C. Liu, Y. Gao, R. Schropp, Z. Li, X. Liu and Y. Mai, *Adv. Sci.*, 2020, 2001013.
- 20 Y. Zhou, L. Wang, S. Chen, S. Qin, X. Liu, J. Chen, D.-J. Xue, M. Luo, Y. Cao, Y. Cheng, E. H. Sargent and J. Tang, *Nat. Photonics*, 2015, 9, 409.
- 21 A. Walsh, D. J. Payne, R. G. Egdell and G. W. Watson, *Chem. Soc. Rev.*, 2011, **40**, 4455–4463.
- 22 J. J. Carey, D. O. Allen, J. P. Scanlon and G. W. Watson, J. Solid State Chem., 2014, 213, 116–125.
- 23 T. J. Whittles, L. A. Burton, J. M. Skelton, A. Walsh,
 T. D. Veal and V. R. Dhanak, *Chem. Mater.*, 2016, 28, 3718–3726.
- 24 T. J. Whittles, T. D. Veal, C. N. Savory, A. W. Welch, F. W. S. Lucas, J. T. Gibbon, M. Birkett, R. J. Potter, D. O. Scanlon, A. Zakutayev and V. R. Dhanak, *ACS Appl. Mater. Interfaces*, 2017, 9, 41916–41926.
- 25 J. H. Scofield, *Theoretical photoionization cross sections* from 1 to 1500 keV, California Univ., Livermore, Lawrence Livermore Lab., technical report, 1973.
- 26 L. Wang, D.-B. Li, K. Li, C. Chen, H.-X. Deng, L. Gao, Y. Zhao, F. Jiang, L. Li and F. Huang, *et al.*, *Nat. Energy*, 2017, 2, 17046.
- 27 C. Chen, Y. Zhao, S. Lu, K. Li, Y. Li, B. Yang, W. Chen,
 L. Wang, D. Li and H. Deng, *et al.*, *Adv. Energy Mater.*, 2017,
 7, 1700866.
- 28 R. J. Mehta, C. Karthik, W. Jiang, B. Singh, Y. Shi, R. W. Siegel, T. Borca-Tasciuc and G. Ramanath, *Nano Lett.*, 2010, 10, 4417–4422.
- 29 J. F. Moulder, W. F. Stickle, P. E. Sobol and K. D. Bomben, *Handbook of X-ray Photoelectron Spectroscopy*, PerkinElmer Corporation, 1992, p. 261.
- 30 N. Fleck, T. D. C. Hobson, C. N. Savory, J. Buckeridge, T. D. Veal, M. R. Correia, D. O. Scanlon, K. Durose and F. Jäckel, *J. Mater. Chem. A*, 2020, 8, 8337–8344.
- 31 T. D. C. Hobson, L. J. Phillips, O. S. Hutter, H. Shiel, J. E. N. Swallow, C. N. Savory, P. K. Nayak, S. Mariotti, B. Das, L. Bowen, L. A. H. Jones, T. J. Featherstone, M. J. Smiles, M. A. Farnworth, G. Zoppi, P. K. Thakur, T.-L. Lee, H. J. Snaith, C. Leighton, D. O. Scanlon, V. R. Dhanak, K. Durose, T. D. Veal and J. D. Major, *Chem. Mater.*, 2020, 32, 2621–2630.
- 32 T. D. C. Hobson, O. S. Hutter, M. Birkett, T. D. Veal and K. Durose, 2018 IEEE 7th World Conference on Photovoltaic

Energy Conversion (WCPEC) (A Joint Conference of 45th IEEE PVSC, 28th PVSEC & 34th EU PVSEC), 2018, 0818–0822.

- 33 H. Song, T. Li, J. Zhang, Y. Zhou, J. Luo, C. Chen, B. Yang,
 C. Ge, Y. Wu and J. Tang, *Adv. Mater.*, 2017, 29, 1700441.
- 34 D. A. Shirley, Phys. Rev. B: Solid State, 1972, 5, 4709-4714.
- 35 G. Kresse and J. Hafner, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1993, 47, 558–561.
- 36 G. Kresse and J. Hafner, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1994, **49**, 14251–14269.
- 37 G. Kresse and J. Furthmüller, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1996, 54, 11169–11186.
- 38 G. Kresse and J. Furthmüller, *Comput. Mater. Sci.*, 1996, 6, 15–50.
- 39 A. V. Krukau, O. A. Vydrov, A. F. Izmaylov and G. E. Scuseria, J. Chem. Phys., 2006, 125, 224106.
- 40 S. Grimme, J. Comput. Chem., 2004, 25, 1463-1473.
- 41 C. N. Savory and D. O. Scanlon, *J. Mater. Chem. A*, 2019, 7, 10739–10744.
- 42 W. Jianqi, F. Daming, W. Wenhui, Z. Minxiu and L. Yiz, *Polym. Degrad. Stab.*, 1991, **31**, 129–140.
- 43 R. Delobel, H. Baussart, J.-M. Leroy, J. Grimblot and L. Gengembre, J. Chem. Soc., Faraday Trans. 1, 1983, 79, 879–891.
- 44 C. D. Wagner, D. A. Zatko and R. H. Raymond, *Anal. Chem.*, 1980, **52**, 1445–1451.
- 45 H. Iwakuro, C. Tatsuyama and S. Ichimura, Jpn. J. Appl. Phys., 1982, 21, 94.
- 46 M. Shenasa, S. Sainkar and D. Lichtman, J. Electron Spectrosc. Relat. Phenom., 1986, 40, 329–337.
- 47 L. Ley, R. A. Pollak, F. R. McFeely, S. P. Kowalczyk and D. A. Shirley, *Phys. Rev. B: Solid State*, 1974, 9, 600.
- 48 L. A. H. Jones, W. M. Linhart, N. Fleck, J. E. N. Swallow, P. A. E. Murgatroyd, H. Shiel, T. J. Featherstone, M. J. S. Smiles, P. K. Thakur, T.-L. Lee, L. J. Hardwick, J. Alaria, F. Jäckel, R. Kudrawiec, L. A. Burton, A. Walsh, J. M. Skelton, T. D. Veal and V. R. Dhanak, *Phys. Rev. Mater.*, 2020, 4, 074602.
- 49 J. D. Major, L. J. Phillips, M. Al Turkestani, L. Bowen, T. J. Whittles, V. R. Dhanak and K. Durose, *Sol. Energy Mater. Sol. Cells*, 2017, 172, 1–10.
- 50 V. Stevanović, S. Lany, D. S. Ginley, W. Tumas and A. Zunger, *Phys. Chem. Chem. Phys.*, 2014, **16**, 3706–3714.
- 51 L. A. Burton and A. Walsh, Appl. Phys. Lett., 2013, 102, 132111.